

Search Notes

Application/Control No.

10/542,554

Examiner

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Applicant(s)/Patent under
Reexamination

BAKALASH ET AL.

Art Unit

2628

SEARCHED

Class	Subclass	Date	Examiner
708	160	1/14/2007	PN
	207	1/14/2007	PN
	671	1/14/2007	PN
	700	1/14/2007	PN
706	4	1/14/2007	PN
340	146.2	1/14/2007	PN
345	422	1/14/2007	PN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
708	207	1/14/2007	
	671	1/14/2007	
340	146.2	1/14/2007	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST search (binary, comparison, segment - SEE ATTACHED)	1/14/2007	PN
Nonpatent Literature (IEEE, ACM, IBM) search (binary, comparison, segment - SEE ATTACHED)	1/14/2007	PN
Inventor Name search	1/14/2007	PN